

T808 800-12-18

Key Parameters

V_{DRM}	1200~1800	V
$I_{\text{T(AV)}}$	850	A
I_{TSM}	14.0	kA
V_{TO}	0.91	V
r_{T}	0.36	mΩ

Applications

- Traction drive
- Motor drive
- Industry converter

Features

- Double-side cooling
- High power capability
- Low loss

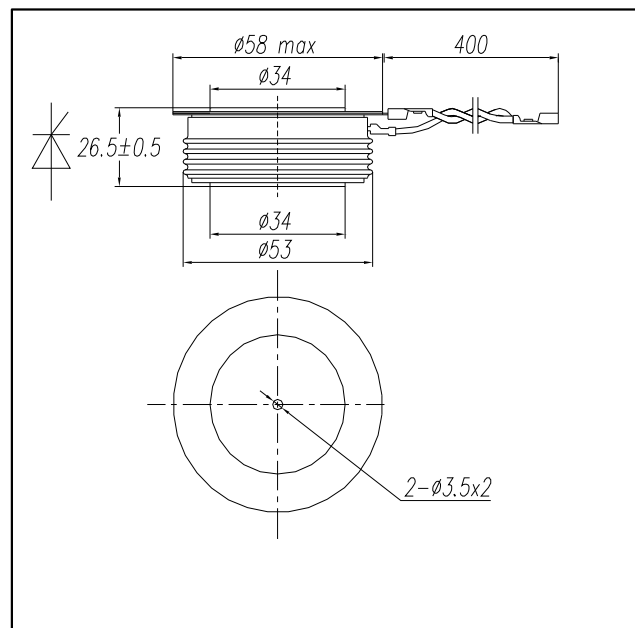
Thermal & Mechanical Data

Symb.	Parameter	Min	Type	Max	Unit
R_{thjc}	Thermal Resistance Junction to Case	-	-	0.035	K / W
R_{thcs}	Thermal Resistance Case to Heatsink	-	-	0.008	K / W
T_{vj}	Junction Temperature	-40	-	125	°C
T_{stg}	Storage Temperature	-40	-	140	°C
F	Mounting Force	-	15	-	kN
m	Weight	-	0.26	-	kg

Voltage Ratings

Device Type	$V_{\text{DRM}}/V_{\text{RRM}}(\text{V})$	Test Conditions
T808 800-12	1200	$T_{\text{vj}} = 125\text{ °C}$
T808 800-14	1400	$I_{\text{DRM}} = 60\text{ mA}$
T808 800-16	1600	$I_{\text{RRM}} = 60\text{ mA}$
T808 800-18	1800	$V_{\text{DM}} = V_{\text{DRM}}, V_{\text{RM}} = V_{\text{RRM}}$ $t_{\text{p}} = 10\text{ ms}$
		$V_{\text{DSM}} = V_{\text{DRM}}$ $V_{\text{RSM}} = V_{\text{RRM}} + 100$

Outline



Current Ratings

Symb.	Parameter	Test Conditions	Min	Type	Max	Unit
$I_{\text{T(AV)}}$	Mean On-State Current	Half Sine Wave, $T_{\text{C}} = 70\text{ °C}$	-	-	850	A
$I_{\text{T(RMS)}}$	RMS On-State Current	$T_{\text{C}} = 70\text{ °C}$	-	-	1335	A
I_{TSM}	Surge (non-repetitive) On-State Current	10ms, Half Sine Wave, $T_{\text{C}} = 125\text{ °C}, V_{\text{R}} = 0$	-	-	14.0	kA
I^2t	Limiting load integral	Sine Wave, 10ms	-	-	98	$10^4\text{ A}^2\text{s}$

T808 800-12-18

Characteristics

Symb.	Parameter	Test Conditions	Min	Type	Max	Unit
V_{TM}	Peak on-state voltage	$T_{vj} = 125\text{ }^{\circ}\text{C}$, $I_{TM} = 1500\text{ A}$	-	-	1.45	V
I_{DRM}	Forward leakage current	$T_{vj} = 125\text{ }^{\circ}\text{C}$, V_{DRM}	-	-	60	mA
I_{RRM}	Reverse leakage current	$T_{vj} = 125\text{ }^{\circ}\text{C}$, V_{RRM}	-	-	60	mA
V_{TO}	Threshold voltage	$T_{vj} = 125\text{ }^{\circ}\text{C}$	-	-	0.91	V
r_T	Slope resistance	$T_{vj} = 125\text{ }^{\circ}\text{C}$	-	-	0.36	m Ω
I_H	Holding current	$T_{vj} = 25\text{ }^{\circ}\text{C}$	-	-	200	mA
I_L	Latching current	$T_{vj} = 25\text{ }^{\circ}\text{C}$	-	-	1000	mA

Dynamic Parameters

Symb.	Parameter	Test Conditions	Min	Type	Max	Unit
dv/dt	Critical rate of rise of off-state voltage	$T_{vj} = 125\text{ }^{\circ}\text{C}$, $0.67V_{DRM}$	1000	-	-	V/ $\mu\text{ s}$
di/dt	Critical rate of rise of on-state current	$T_{vj} = 125\text{ }^{\circ}\text{C}$, $V_{DM} = 0.67V_{DRM}$, $I_{TM} = 1000\text{ A}$ $I_{FG} = 2\text{ A}$, $tr = 0.5\text{ }\mu\text{ s}$, $f = 50\text{ Hz}$	-	-	200	A/ $\mu\text{ s}$
t_d	Delay time	$T_{vj} = 25\text{ }^{\circ}\text{C}$, $V_{DM} = 0.5V_{DRM}$, $I_{TM} = 1000\text{ A}$ $I_{FG} = 2\text{ A}$, $tr = 0.5\text{ }\mu\text{ s}$	-	-	3.0	$\mu\text{ s}$
t_q	Turn-off time	$T_{vj} = 125\text{ }^{\circ}\text{C}$, $V_{DM} = 0.67V_{DRM}$, $dv/dt = 20\text{ V}/\mu\text{ s}$, $V_R = 200\text{ V}$ $di_T/dt = -10\text{ A}/\mu\text{ s}$, $I_T = 1000\text{ A}$	-	200	-	$\mu\text{ s}$
Q_{rr}	Recovery Charge	$T_{vj} = 125\text{ }^{\circ}\text{C}$, $di_T/dt = -10\text{ A}/\mu\text{ s}$, $V_R = 200\text{ V}$, $I_T = 1000\text{ A}$	-	-	2000	$\mu\text{ C}$
I_{rr}	Reverse recovery current		-	-	120	A

Gate Parameters

Symb.	Parameter	Test Conditions	Min	Type	Max	Unit
I_{GT}	Gate trigger current	$T_{vj} = 25\text{ }^{\circ}\text{C}$	-	-	300	mA
V_{GT}	Gate trigger voltage	$T_{vj} = 25\text{ }^{\circ}\text{C}$	-	-	3.0	V
I_{GD}	Gate non-trigger current	$T_{vj} = 125\text{ }^{\circ}\text{C}$, $V_D = 0.4V_{DRM}$	10	-	-	mA
V_{GD}	Gate non-trigger voltage	$T_{vj} = 125\text{ }^{\circ}\text{C}$, $V_D = 0.4V_{DRM}$	0.3	-	-	V
V_{FGM}	Peak forward gate voltage		-	-	12	V
V_{RGM}	Peak reverse gate voltage		-	-	5	V
I_{FGM}	Peak forward gate current		-	-	4	A
P_{GM}	Gate power losses		-	-	20	W
$P_{G(AV)}$	Gate power losses (mean)		-	-	4	W

T808 800-12-18

1

Max. on-state characteristic model

$$V_T = A + B \cdot \ln(I_T) + C \cdot I_T + D \cdot \sqrt{I_T}$$

	25 °C	125 °C
A	0.727213	0.440868
B	0.0264798	0.0637241
C	0.000192685	0.000258024
D	0.00813017	0.00399011

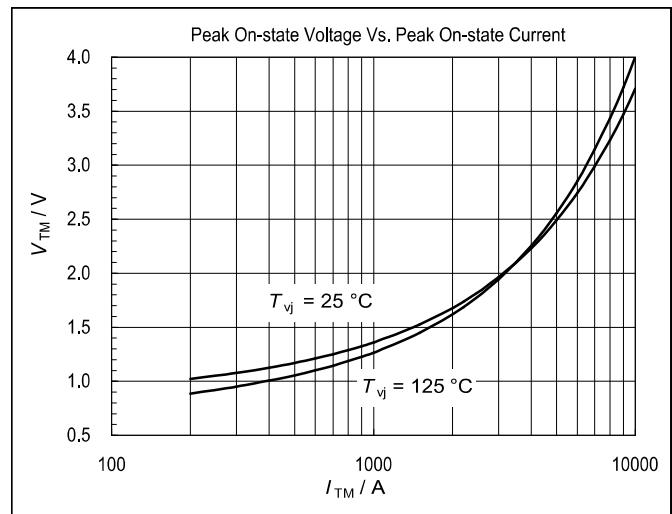


Fig1. Peak On-state Voltage Vs. Peak On-state Current

Transient thermal impedance function
(double side cooled)

$$R_{thjc}(t) = \sum_{i=1}^n R_{thi} \cdot \left(1 - e^{-\frac{t}{\tau_i}} \right)$$

i	1	2	3	4
R _{thi} (K/kW)	19.719	4.2406	7.9638	3.0437
τ _i (s)	0.7086	0.1436	0.0362	0.0021

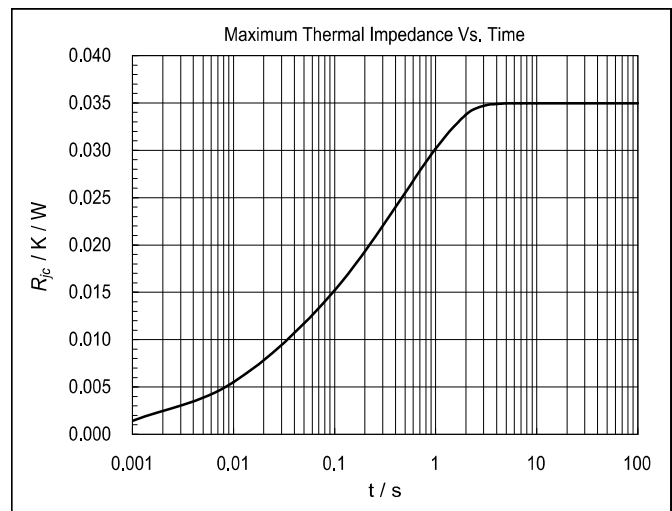


Fig2. Maximum Thermal Impedance Vs. Time

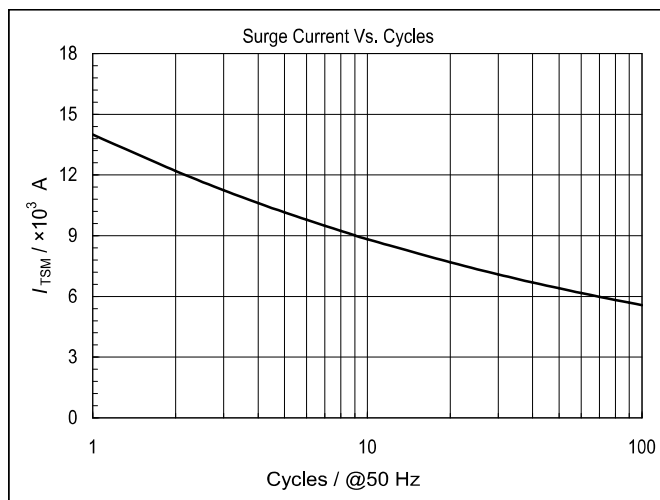


Fig3. Surge Current Vs. Cycles

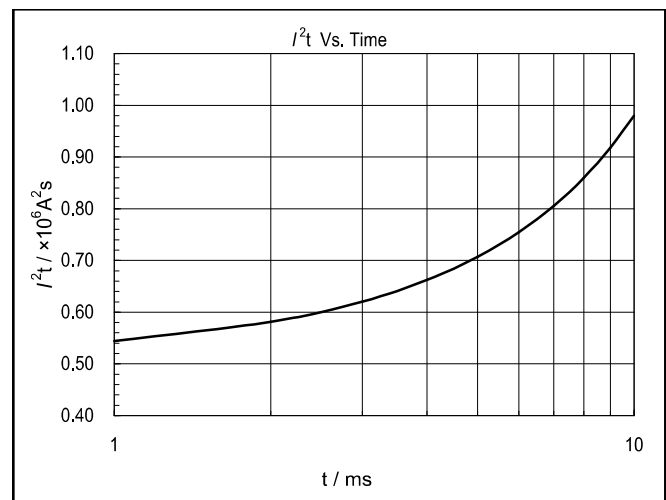


Fig4. I² t Vs. Time

T808 800-12-18

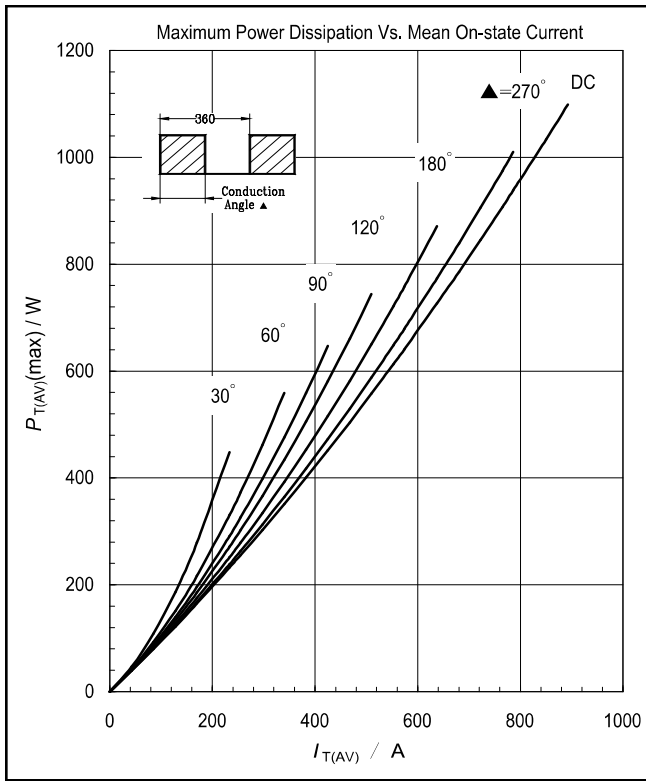


Fig5. Maximum Power Dissipation Vs. Mean On-state Current

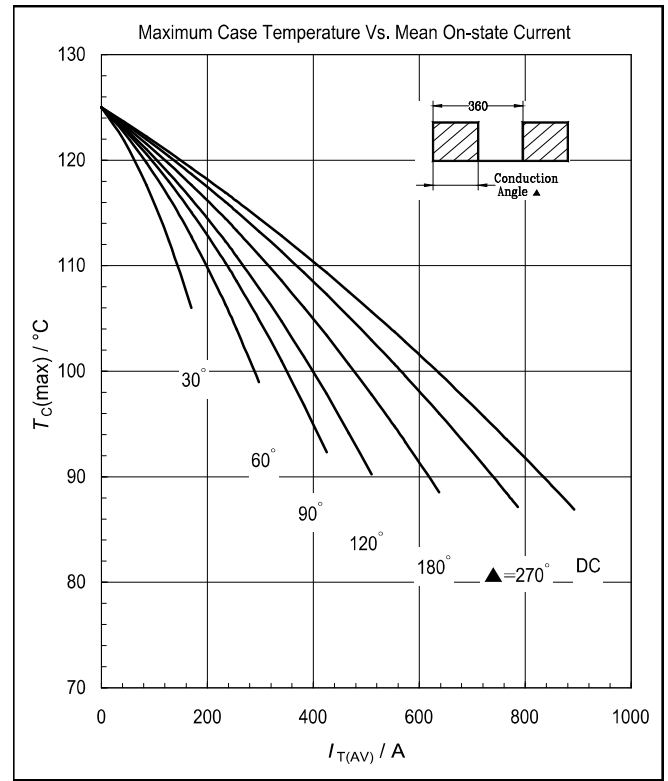


Fig6. Maximum Case Temperature Vs. Mean On-state Current

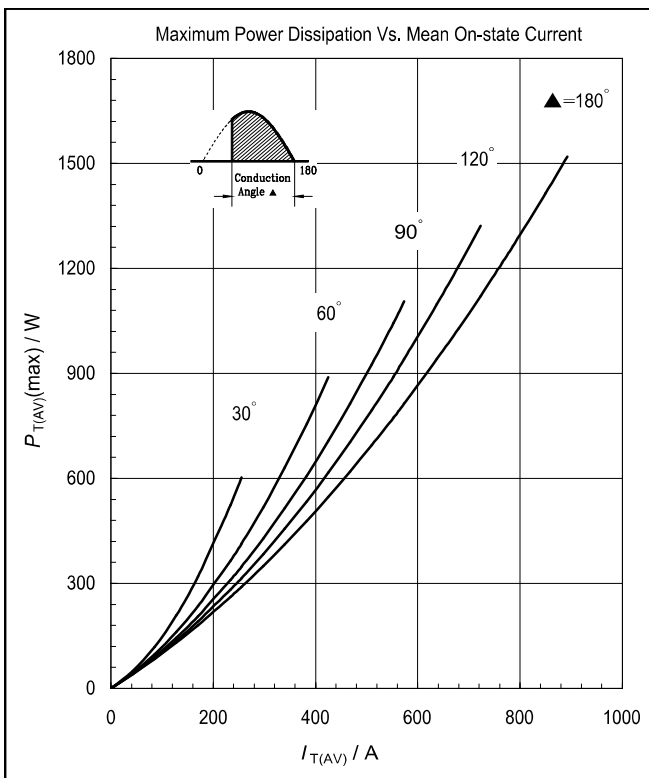


Fig7. Maximum Power Dissipation Vs. Mean On-state Current

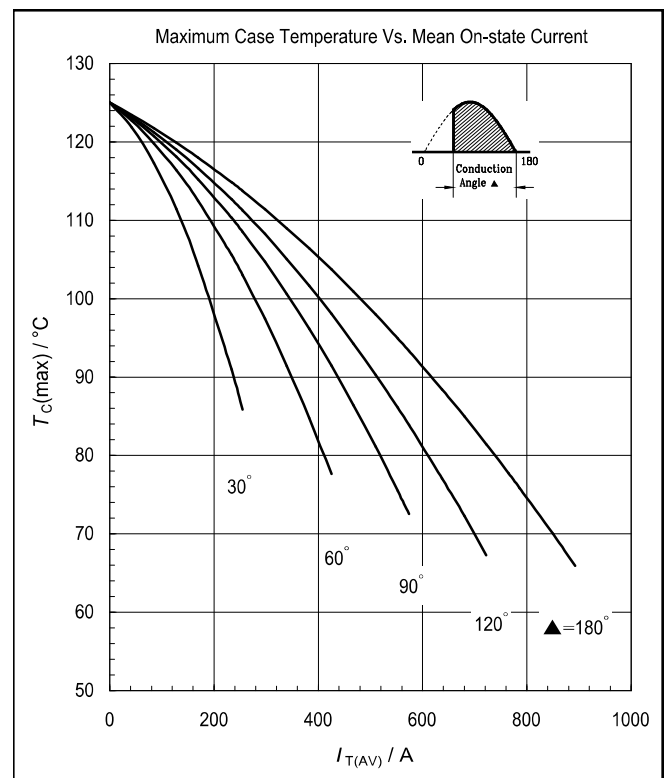


Fig8. Maximum Case Temperature Vs. Mean On-state Current

T808 800-12-18

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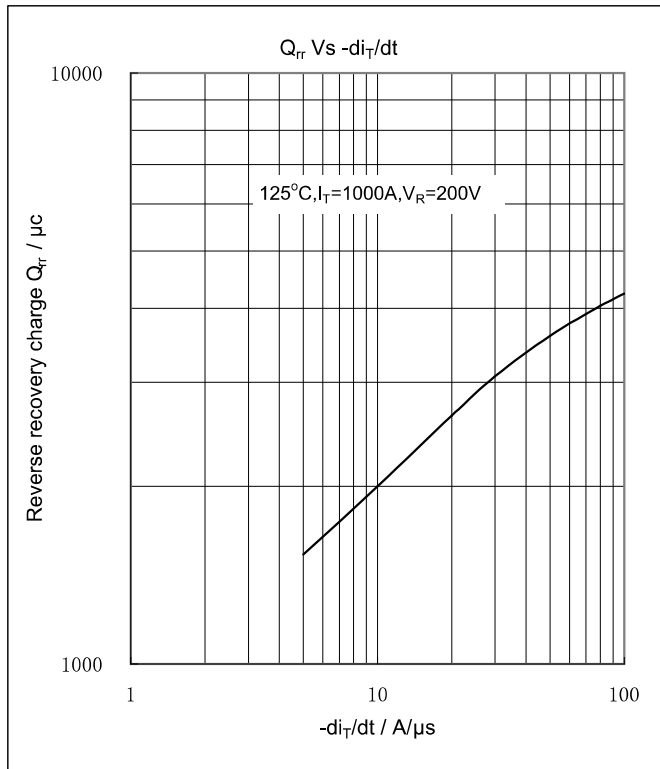


Fig9. Reverse recovery charge Vs. $-di_T/dt$

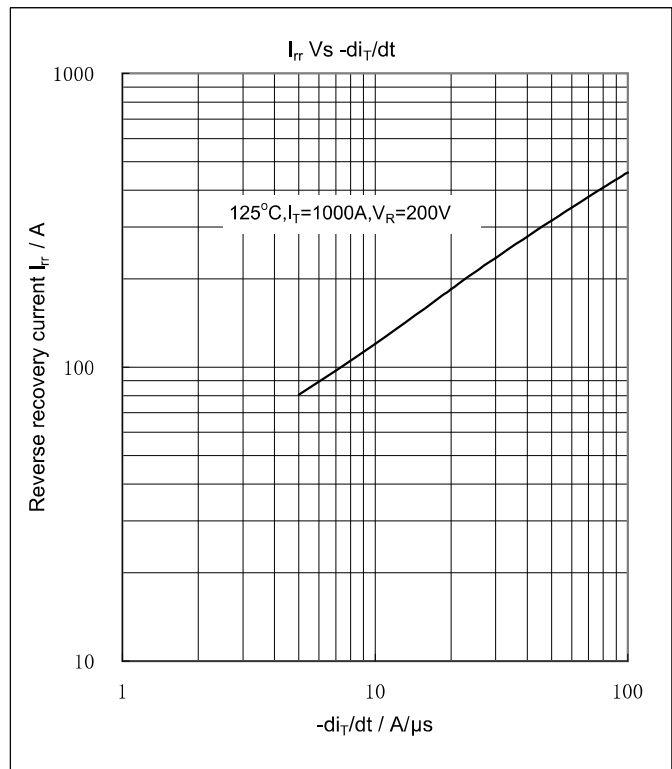


Fig10. Reverse recovery current Vs. $-di_T/dt$

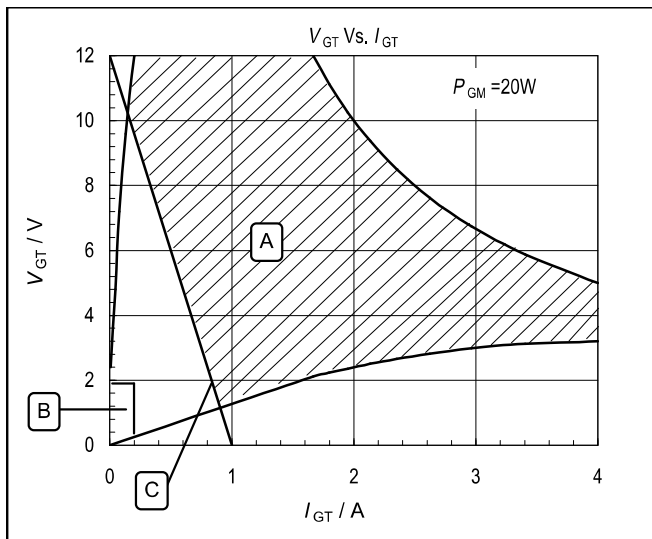


Fig11. V_{GT} Vs. I_{GT}

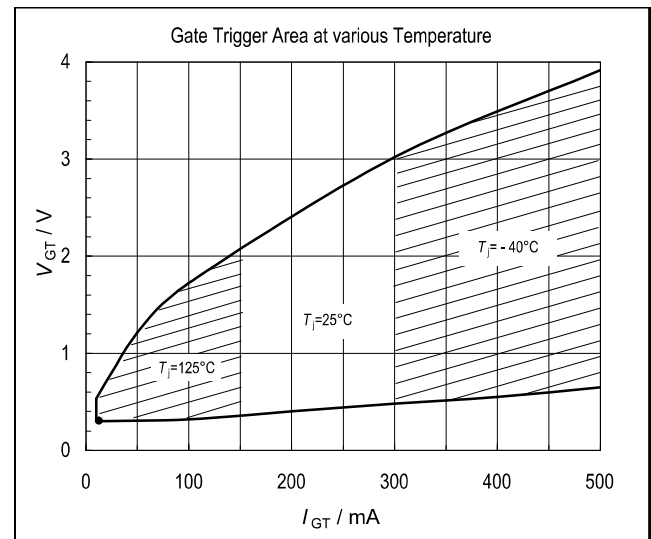


Fig12. Gate Trigger Area at various Temperature

A is Recommended Triggering Area.

B is Unreliable Triggering Area.

C is Recommended Gate Load Line.